Search Notes			

	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/630,631	LEE, CHUNG KEE
	Examiner	Art Unit
=	Frederick C. Nicolas	3754

SEARCHED			
Class	Subclass	Date	Examiner
222	212,494, 490, 325,328, 335,531	2/7/2005	NK
222	556,562	6/5/2006	FN
222	213-215	6/5/2006	FN
222	491	6/5/2006	FN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
222	212	6/5/2006	FN
222	490	6/5/2006	FN
222	494	6/5/2006	FN
222	/562	6/5/2006	FN

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated search thru east.	2/16/2006	FN
Updated search thru east including additional search. Interference search also conducted.	6/5/2006	FN
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